MOSFET – Power, Single, P-Channel, UDFN, 2.0x2.0x0.55 mm -20 V, -8.2 A

Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- Ultra Low R_{DS(on)}
- ESD Diode-Protected Gate
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Optimized for Power Management Applications for Portable Products, such as Cell Phones, Media Tablets, PMP, DSC, GPS, and Others
- Battery Switch
- High Side Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	-20	V
Gate-to-Source Voltage			V _{GS}	±8.0	V
Continuous Drain	Steady	T _A = 25°C	I _D	-8.2	Α
Current (Note 1) Continuous Drain	State	T _A = 85°C		-5.9	
Current (Note 1)	t ≤ 5 s	T _A = 25°C		-12.2	
Power Dissipa- tion (Note 1)	Steady State	T _A = 25°C	P _D	1.7	W
	t ≤ 5 s	T _A = 25°C		3.8	
Continuous Drain	Steady	T _A = 25°C	I _D	-5.1	Α
Current (Note 2)	State	T _A = 85°C		-3.7	
Power Dissipation (Note 2) T _A = 25°C		P_{D}	0.7	W	
Pulsed Drain Current tp = 10 μs		I _{DM}	-25	Α	
Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
ESD (HBM, JESD22-A114)			V _{ESD}	2000	V
Source Current (Body Diode) (Note 2)			Is	-1.7	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

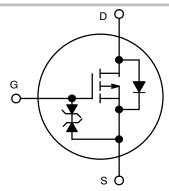
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.



ON Semiconductor®

www.onsemi.com

MOSFET				
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
-20 V	18 mΩ @ -4.5 V			
	25 mΩ @ -2.5 V	-8.2 A		
	50 mΩ @ –1.8 V	0.271		
	90 mQ @ _1 5 V			



P-Channel MOSFET

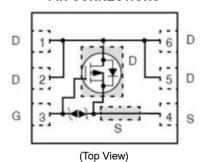
S MARKING DIAGRAM UDFN6 CASE 517BG MARKING DIAGRAM AC M AC M -

AC = Specific Device Code M = Date Code

■ = Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient – Steady State (Note 3)	$R_{\theta JA}$	72	
Junction-to-Ambient – $t \le 5$ s (Note 3)		33	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	$R_{\theta JA}$	189	

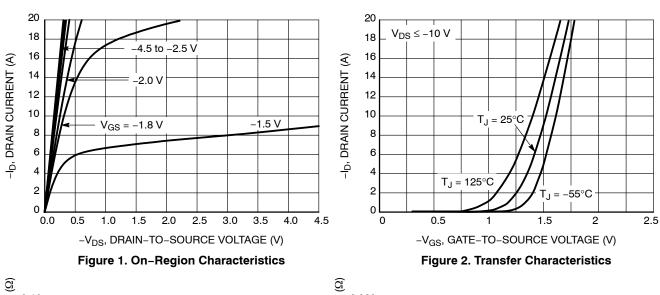
- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.

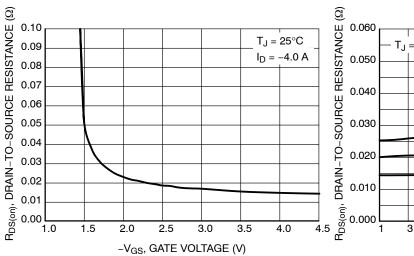
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

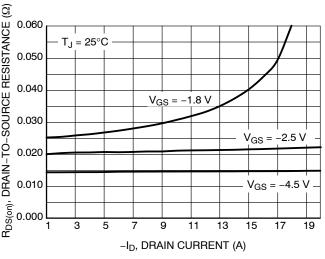
Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I_D = -250 μA, ref to 25°C			+10		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -20 \text{ V}$	T _J = 25°C			-1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, \	/ _{GS} = ±5.0 V			±5	μΑ
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$,	I _D = -250 μA	-0.4		-1.0	V
Negative Threshold Temp. Coefficient	V _{GS(TH)} /T _J				3.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -4.5	V, I _D = -7.0 A		14.6	18	mΩ
		V _{GS} = -2.5	V, I _D = -5.0 A		19	25	
		V _{GS} = -1.8	V, I _D = -3.0 A		25	50	
		V _{GS} = -1.5	V, I _D = -1.0 A		40	90	
Forward Transconductance	9FS	V _{DS} = -5 V	′, I _D = −3.0 A		40		S
CHARGES, CAPACITANCES & GATE	RESISTANCE	•					
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,} $ $V_{DS} = -15 \text{ V}$			2240		pF
Output Capacitance	C _{OSS}				240		
Reverse Transfer Capacitance	C _{RSS}				210		
Total Gate Charge	Q _{G(TOT)}				28		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V};$ $I_D = -4.0 \text{ A}$			1.0		1
Gate-to-Source Charge	Q _{GS}				2.9		
Gate-to-Drain Charge	Q_{GD}				8.8		
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Note 6)	•					
Turn-On Delay Time	t _{d(ON)}				8.6		ns
Rise Time	t _r	Voc = -45 V	Vpp = -15 V		15		1
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = -4.5 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -4.0 \text{ A}, R_{G} = 1 \Omega$			150		
Fall Time	t _f				88		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V, T _J = 25°C	T _J = 25°C		0.63	1.0	V
		$I_{S} = -1.0 \text{ A}$	T _J = 125°C		0.50		
Reverse Recovery Time	t _{RR}		1 ~		26.1		ns
Charge Time	t _a	$V_{GS} = 0 \text{ V, dls/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -1.0 \text{ A}$			10.2		
Discharge Time	t _b				15.9		
Reverse Recovery Charge	Q _{RR}				12		nC

- 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS







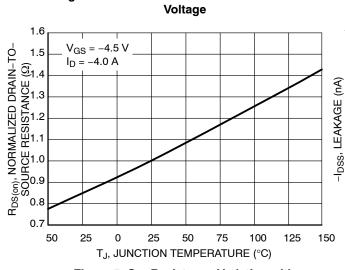


Figure 3. On-Resistance vs. Gate-to-Source

Figure 4. On-Resistance vs. Drain Current and Gate Voltage

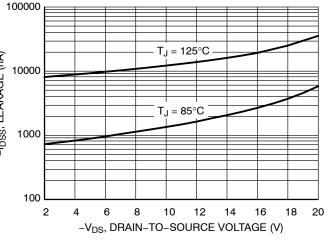


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

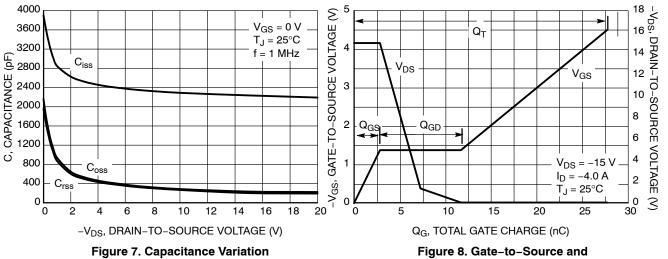


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

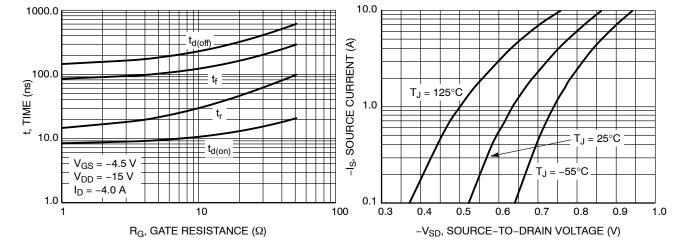


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

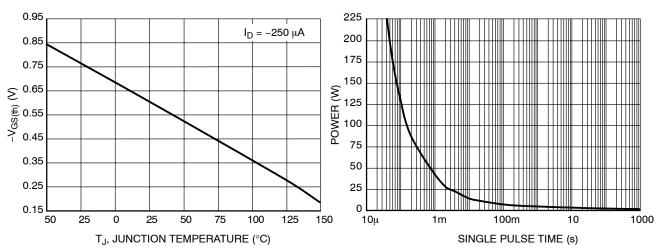


Figure 11. Threshold Voltage

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

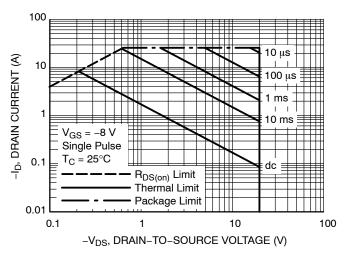


Figure 13. Maximum Rated Forward Biased Safe Operating Area

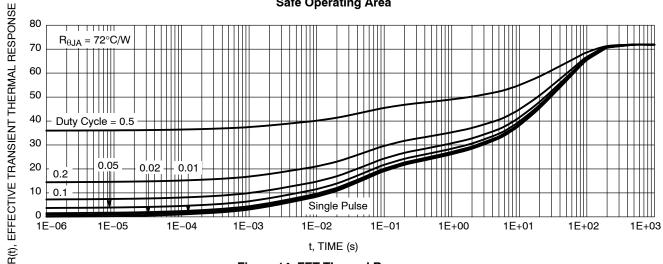


Figure 14. FET Thermal Response

DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTLUS3A18PZTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A18PZTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS3A18PZTCG	UDFN6 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

DETAIL A

6X L

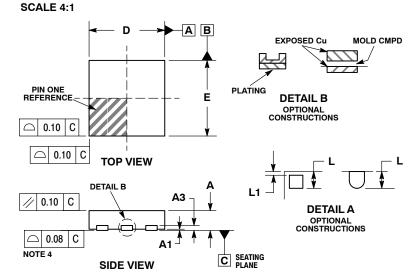
E2

J1

BOTTOM VIEW



DATE 04 FEB 2010



С 0.10

0.05 C NOTE 5

NOTE 3

Ф

0.10 С Α

С 0.05

Α



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION & APPLIES TO PLATED TERMINAL AND IS
 MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL
 COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS
 THE TERMINALS. 3.
- 1. CENTER TERMINAL LEAD IS OPTIONAL CENTER TERMINAL IS CONNECTED TO TERMINAL LEAD # 4.
 2. LEADS 1, 2, 5 AND 6 ARE TIED TO THE FLAG.

	MILLIMETERS			
DIM	MIN	MAX		
Α	0.45	0.55		
A1	0.00	0.05		
A3	0.13	REF		
b	0.25	0.35		
b1	0.51	0.61		
D	2.00 BSC			
D2	1.00	1.20		
E	2.00 BSC			
E2	1.10	1.30		
е	0.65 BSC			
K	0.15 REF			
J	0.27 BSC			
J1	0.65 BSC			
L	0.20	0.30		
L1	0.10			
L2	0.20 0.30			

GENERIC MARKING DIAGRAM*



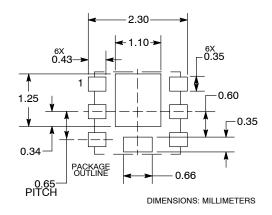
XX = Specific Device Code

M = Date Code

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present.

RECOMMENDED **MOUNTING FOOTPRINT**



DOCUMENT NUMBER:	98AON48158E	Electronic versions are uncontrolled except when accessed directly from the Document Repositor Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.		
DESCRIPTION:	UDFN6 2X2, 0.65P		PAGE 1 OF 1	

ON Semiconductor and (III) are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, Onsemi, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA class 3 medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase

ADDITIONAL INFORMATION

TECHNICAL PUBLICATIONS:

 $\textbf{Technical Library:} \ \underline{www.onsemi.com/design/resources/technical-documentation}$

onsemi Website: www.onsemi.com

ONLINE SUPPORT: www.onsemi.com/support

For additional information, please contact your local Sales Representative at

www.onsemi.com/support/sales